

Notice of References Cited	Application/Control No. 09/911,268		Applicant(s)/Patent Under Reexamination ECKEL ET AL.	
	Examiner Tae H. Yoon		Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,220,790	05-2007	Seidel et al.	524/127
*	B	US-7,186,767	03-2007	Seidel et al.	524/127
*	C	US-7,067,567	06-2006	Seidel et al.	523/201
*	D	US-7,019,057	03-2006	Seidel et al.	524/127
*	E	US-6,828,366	12-2004	Seidel et al.	524/127
*	F	US-6,767,944	07-2004	Zobel et al.	524/127
*	G	US-6,757,465	06-2004	Yokokawa et al.	385/113
*	H	US-6,713,544	03-2004	Eckel et al.	524/127
*	I	US-2004/0039091 A1	02-2004	Eckel et al.	524/121
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.